

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Patricia T. Nguyen	Art Unit 2817	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,452,713 B1	09-2002	White, Christopher A.	359/322
	B	US-6,538,621 B1	03-2003	Sievenpiper et al.	343/909
	C	US-5,973,823	10-1999	Koops et al.	359/322
	D	US-6,603,558 B2	08-2003	Murakowski et al.	356/461
	E	US-6,535,665 B1	03-2003	Kim et al.	385/28
	F	US-6,285,020 B1	09-2001	Kim et al.	250/216
	G	US-6,134,043	10-2000	Johnson et al.	359/237
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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